Se	Search Notes			

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/625,364	XIN ET AL.	
Examiner	Art Unit	
Sherali Ishrat	2624	

SEARCHED			
Class	Subclass	Date	Examiner
382	232-253	6/5/2007	IS
375	240.01-	6/5/2007	IS
	240.22		
348	698	6/5/2007	IS
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INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
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(INCLUDING SEARCH	STRATEGY	)
	DATE	EXMR
IEEE,EAST	6/5/2007	IS
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